



Designation: **D 2520 – 9501**

An American National Standard

Standard Test Methods for Complex Permittivity (Dielectric Constant) of Solid Electrical Insulating Materials at Microwave Frequencies and Temperatures to 1650°C¹

This standard is issued under the fixed designation D 2520; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ε) indicates an editorial change since the last revision or reapproval.

This standard has been approved for use by agencies of the Department of Defense.

1. Scope

1.1 These test methods cover the determination of relative (Note 1) complex permittivity (dielectric constant and dissipation factor) of nonmagnetic solid dielectric materials.

NOTE 1—The word “relative” is often omitted.

1.1.1 *Test Method A* is for specimens precisely formed to the inside dimension of a waveguide.

1.1.2 *Test Method B* is for specimens of specified geometry that occupy a very small portion of the space inside a resonant cavity.

1.1.3 *Test Method C* uses a resonant cavity with fewer restrictions on specimen size, geometry, and placement than Test Methods A and B.

1.2 Although these methods are used over the microwave frequency spectrum from around 0.5 to 50.0 GHz, each octave increase usually requires a different generator and a smaller test waveguide or resonant cavity.

1.3 Tests at elevated temperatures are made using special high-temperature waveguide and resonant cavities.

1.4 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Referenced Documents

2.1 *ASTM Standards:*

~~D 150 Test Methods~~

~~A 893 Test Method for AC Loss Characteristics and Permittivity (Dielectric Constant) Complex Dielectric Constant of Solid~~

¹ These test methods are under the jurisdiction of ASTM Committee ~~D-9~~ D09 on Electrical and Electronic Insulating Materials and are the direct responsibility of Subcommittee D09.12 on Electrical Tests.

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